

<b>Issue Classification</b>				Application/Control No.			Applicant(s)/Patent under Reexamination		
				10/635,667			HAYASHI, YUKA		
				Examiner			Art Unit		
				Lana N. Le			2618		

ORIGINAL				CROSS REFERENCE(S)						
CLASS		SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
455		575.1	455	90.1	344	346				
INTERNATIONAL CLASSIFICATION				348	333.05					
H	0	4	M	1/00						
				/						
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				<i>Lana N. Le</i> Primary Examiner Technology Center 2600 <i>Lana N. Le</i> (Primary Examiner)			Total Claims Allowed: 18			
							3-01-07		(Date)	
----- (Assistant Examiner) (Date) <i>Jd</i> <i>3/5/07</i> (Legal Instruments Examiner) (Date)							O.G. Print Claim(s)	O.G. Print Fig.		
							1	3		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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3	5	35	65	95	125	155	185
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6	12	42	72	102	132	162	192
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17	15	45	75	105	135	165	195
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